Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10799001	SCHMANDT ET AL.
Examiner	Art Unit
Flores, Leon	2611

SEARCHED						
Class	Subclass	Date	Examiner			
375	132-135	4/9/2007	LF			
370	329-334	4/9/2007	LF			
455	450	4/9/2007	LF			

SEARCH NOTES				
Search Notes	Date	Examiner		
Consulted with SPE David Payne in regards to the patentability of the claims.	4/23/2007	LF		
Search in IEEE.	4/9/2007	LF		
Checked for double patenting.	4/4/2007	LF		
Consulted with SPE David Payne in regards to the amendments.	9/27/2007	LF		
Consulted with SPE David Payne in regards to the AF.	2/28/2008	LF		
Consulted with SPE David Payne in regards to the amendments.	9/11/2008	LF		
Consulted with SPE David Payne in regards to the RCE.	3/13/2009	LF		
Consulted with SPE David Payne in regards to the arguments.	9/18/2009	LF		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examine	

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